Search Notes			

Application/Control No.	Applica Reexam
10/514 045	

Applicant(s)/Patent under Reexamination

10/541,615 Examiner

L. E. Crane

IMAMURA ET AL.

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SEARCHED				
Class	Subclass	Date	Examiner	
536	001.110, 029.200	11/16/2006	LEC	
514	023.000	11/16/2006	LEC	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
536	001.110	11/16/2006	LEC		
536	029.200	11/16/2006	LEC		
514	023.000	11/16/2006	LEC		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Structure search submitted by applicant: see search for strategies - reviewed on or before the date noted	11/16/2006	LEC
File CAPLUS structure search by examiner - see search for strategy	11/16/2006	LEC